

# Contents

<b>Preface</b>	<b>7</b>
<b>Summary: WIT report 2010</b>	<b>9</b>
<b>I Imaging</b>	<b>13</b>
• <b>Higher-resolution determination of zero-offset Common-Reflection-Surface (CRS) stack parameters</b> . . . . .	<b>15</b>
<i>E.G. Asgedom, M. Tygel, and L.-J. Gelius</i>	
• <b>A comparison of splitting techniques for 3D FFD migration</b> . . . . .	<b>27</b>
<i>J.C. Costa, D. Mondini, J. Schleicher, and A. Novais</i>	
• <b>Diffraction imaging based on the diffraction operator</b> . . . . .	<b>42</b>
<i>J.J.S. Figueiredo, F. Oliveira, E. Esmi, L. Freitas, A. Novais, and J. Schleicher</i>	
• <b>CRS-beam PSDM : Kirchhoff-beam prestack depth migration using the CRS operator</b>	<b>56</b>
<i>G. Garabito, C.A.S. Ferreira, J.C.R. Cruz</i>	
• <b>Velocity Analysis by Focusing Diffractions Simulated from CRS-attributes</b> . . . . .	<b>67</b>
<i>G. Garabito, W. Söllner, W. Lima and I.G. Oliveira</i>	
• <b>Coherence measures in automatic time migration velocity analysis</b> . . . . .	<b>75</b>
<i>J.S. Maciel, J.C. Costa, and J. Schleicher</i>	
• <b>A strategy for 3D CRS parameter estimation: the Tournemire site case study</b> . . . . .	<b>89</b>
<i>H. Perroud, M. Tygel, A. Mahamat, D. Rousset</i>	
• <b>Acoustic Full Waveform Tomography of marine reflection seismic data</b> . . . . .	<b>98</b>
<i>A. Przebindowska, A. Kurzmann, D. Köhn, T. Bohlen</i>	
• <b>A model-based approach to the Common-Diffraction-Surface Stack</b> . . . . .	<b>121</b>
<i>H. Shahsavani and J. Mann</i>	
• <b>Localization of seismic events in 3D media by diffraction stacking</b> . . . . .	<b>134</b>
<i>O. Zhebel, D. Gajewski, and C. Vanelle</i>	
<b>II Modeling</b>	<b>143</b>
• <b>Image-ray tomography</b> . . . . .	<b>145</b>
<i>S. Dell and D. Gajewski</i>	
• <b>Common-Reflection-Surface-based workflow for diffraction imaging</b> . . . . .	<b>158</b>
<i>S. Dell and D. Gajewski</i>	
• <b>Reflection, Diffraction and Resolution</b> . . . . .	<b>175</b>
<i>T. Kaschwich, H. Gjøystdal, I. Lecomte, and E. Iversen</i>	
• <b>Modelling and prestack reverse-time migration by the Rapid Expansion Method with time-stepping</b> . . . . .	<b>186</b>
<i>E. Tessmer</i>	
<b>III Other topics</b>	<b>199</b>
• <b>From Time to Depth with CRS Attributes</b> . . . . .	<b>201</b>
<i>M. Baykulov, S. Dümmong, and D. Gajewski</i>	

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• <b>Trace interpolation and extrapolation with partial CRS stacks . . . . .</b>	<b>209</b>
<i>J.S. Dramsch and D. Gajewski</i>	
• <b>Fast estimation of CRS parameters using local slopes in inhomogeneous media . . . . .</b>	<b>218</b>
<i>L.T. Santos, J. Schleicher, J.C. Costa, and A. Novais</i>	
• <b>Depth conversion of zero-offset and time-migrated reflections . . . . .</b>	<b>232</b>
<i>M. Tygel, B. Ursin, E. Iversen, and M.V. de Hoop</i>	
• <b>A new stacking operator for curved subsurface structures . . . . .</b>	<b>247</b>
<i>C. Vanelle, B. Kashtan, S. Dell, and D. Gajewski</i>	
<b>The Wave Inversion Technology Consortium</b>	<b>255</b>
<b>WIT research personnel</b>	<b>259</b>
<b>List of WIT sponsors</b>	<b>269</b>